

**Search Notes**

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Examiner

Benjamin C. Lee

Applicant(s)/Patent under  
Reexamination

SMITH ET AL.

Art Unit

2612

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EASt (Text search history printout)	6/7/2007	/BL/
	6/2/2007	/BL/